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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
09/480,076	01/10/2000	RICKIE C. LAKE	MI40-274	3868
21567 7	590 03/27/2003			
	JOHN ROBERTS GR	EXAMINER		
601 W. FIRST SUITE 1300	AVENUE	HARAN, JOHN T		
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			DATE MAILED: 03/27/2003	

Please find below and/or attached an Office communication concerning this application or proceeding.

		Application	eation No. Applicant(s)					
		09/480,076		LAKE, RICKIE C.				
Office Action	Examiner		Art Unit					
		John T. Hara		1733				
The MAILING DATE of this communication appears on the cover sheet with the correspondence address Period for Reply								
 If NO period for reply is specified a Failure to reply within the set or ex Any reply received by the Office later earned patent term adjustment. See 	FHIS COMMUNICATION. The under the provisions of 37 CFR 1.1 ailing date of this communication. The is less than thirty (30) days, a reply bove, the maximum statutory period was tended period for reply will, by statute the tert than three months after the mailing.	36(a). In no event, y within the statutor will apply and will experied the applicate the applicate the second control of the second	however, may a reply be tim y minimum of thirty (30) days pire SIX (6) MONTHS from to to become ABANDONED	ely filed s will be considered timel the mailing date of this or (35 U.S.C. § 133).				
Status		- h						
,								
2a)⊠ This action is FINA	•	is action is no						
3) Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213. Disposition of Claims								
	! 23-38 and 51-59 is/are ne	ending in the a	application					
• • • • • • • • • • • • • • • • • • • •	4)⊠ Claim(s) 9,10,12,14,23-38 and 51-59 is/are pending in the application. 4a) Of the above claim(s) is/are withdrawn from consideration.							
•	5) Claim(s) is/are allowed.							
6)⊠ Claim(s) <u>9,10, 12, 14, 23-38, and 51-59</u> is/are rejected.								
7) Claim(s) is/ar		,						
		r election real	uirement.					
8) Claim(s) are subject to restriction and/or election requirement. Application Papers								
9) The specification is objected to by the Examiner.								
10) ☐ The drawing(s) filed on is/are: a) ☐ accepted or b) ☐ objected to by the Examiner.								
Applicant may not re	quest that any objection to the	e drawing(s) be	held in abeyance. Se	ee 37 CFR 1.85(a).				
11)☐ The proposed drawing correction filed on is: a)☐ approved b)☐ disapproved by the Examiner.								
If approved, corrected drawings are required in reply to this Office action.								
12)☐ The oath or declaration is objected to by the Examiner.								
Priority under 35 U.S.C. §§ 1	19 and 120							
13) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).								
a) ☐ All b) ☐ Some * c) ☐ None of:								
1. Certified copies of the priority documents have been received.								
2. Certified copie	2. Certified copies of the priority documents have been received in Application No							
 Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)). * See the attached detailed Office action for a list of the certified copies not received. 								
14) Acknowledgment is made of a claim for domestic priority under 35 U.S.C. § 119(e) (to a provisional application).								
	of the foreign language pro nade of a claim for domest							
15) Acknowledgment is made of a claim for domestic priority under 35 U.S.C. §§ 120 and/or 121. Attachment(s)								
Notice of References Cited (PT 2) Notice of Draftsperson's Patent Information Disclosure Statement	Drawing Review (PTO-948)	5)		(PTO-413) Paper No Patent Application (PT				

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DETAILED ACTION

1. This Office Action is in response to the amendment filed on 2/10/03.

Claim Rejections - 35 USC § 112

- 2. The following is a quotation of the second paragraph of 35 U.S.C. 112:
 - The specification shall conclude with one or more claims particularly pointing out and distinctly claiming the subject matter which the applicant regards as his invention.
- 3. Claims 55-56 are rejected under 35 U.S.C. 112, second paragraph, as being indefinite for failing to particularly point out and distinctly claim the subject matter which applicant regards as the invention.

Claims 55 and 56 are indefinite because they require specific weight parts of silane, while independent claim 1, from which claims 55 and 56 depend, requires a glycidoxy methoxy silane. It is unclear if the silane referred to in claims 55 and 56 is a glycidoxy methoxy silane or any type of silane. It is suggested to amend the claims to read glycidoxy methoxy silane.

Claim Rejections - 35 USC § 103

- 4. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 5. Claims 9, 12, 14, and 55-56 are rejected under 35 U.S.C. 103(a) as being unpatentable over Chen et al (U.S. Patent 4,975,221) in view of Tsukagoshi et al (U.S.

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Patent 5,843,251), Kropp et al (U.S. Patent 5,362,421), or Inoue et al (U.S. Patent 5,728,473).

Chen et al discloses a curable epoxy adhesive for use in attaching electrical components together, such as semiconductor die or chips to a substrate, to form a connection wherein the epoxy adhesive contains an electrically conductive filler and an epoxy functional silane adhesion promoter (Column 1, lines 5-11 and Column 3, line 59 to Column 4, line 5). The adhesion promoter is present in the curable adhesive composition less than or equal to about 2% by weight or 1% by weight (Column 4, lines 15-20).

While Chen et al is silent towards the specifics of using the adhesive to electrically interconnect electrical components, it would have been obvious to one of ordinary skill in the art at the time the invention was made that in order to form an electrical connection between two electrical components with an adhesive, the adhesive must be interposed between the components and cured.

Chen et al are silent towards the type of silane utilized as the adhesion promotor, however Chen et al do teach any type of epoxy terminated silanes are suitable as the adhesion promotor (Column 4, lines 4-5).

Glycidoxy methoxy silanes are well known and conventional adhesion promotors/coupling agents, as evidenced for example in Tsukagoshi et al, Kropp et al, and Inoue et al. Tsukagoshi et al is directed to a method for electrically connecting circuits by interposing an epoxy adhesive between two circuits (Column 3, lines 30-35). The reference teaches adding a silane coupling agent to the epoxy, such as

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glycidoxypropyltrimethoxysilane, in order to strengthen the adhesive interface of the circuits and to improve moisture resistance, (Column 10, line 62 to Column 11, line 12). Kropp et al also teach adding a silane coupling agent to a curable, electrically conductive epoxy adhesive, such as glycidoxypropyltrimethoxysilane, for interconnecting electronic parts (Abstract, Column 6, lines 1-9). Inoue et al also teach adding a silane coupling agent to a curable epoxy adhesive, such as glycidoxypropyltrimethoxysilane, for interconnecting electronic components.

One skilled in the art would have readily appreciated that Chen et al teach using epoxy functional silanes in general as an adhesion promoter and one skilled in the art also would have appreciated, given the general teaching of Chen, using known epoxy functional silanes as the adhesion promoter. Glycidoxy methoxy silanes, such as glycidoxypropyltrimethoxysilane, are well known and conventional epoxy functional silanes used as adhesion promoters, as evidenced by Tsukagoshi et al, Kropp et al, and Inoue et al. It would have been obvious to one of ordinary skill in the art at the time the invention was made to utilize a known epoxy functional silane adhesion promotor, such as glycidoxypropyltrimethoxysilane, in the epoxy adhesive in the method of Chen et al.

Regarding claims 55-56, it is well known and conventional for epoxy to be made conductive by adding silver to it, as shown for example in Chen et al (Column 3, lines 62-65) and one skilled in the art would have readily appreciated it would have been within the purview of one skilled in the art to determine the necessary amount of adhesion promoter to add to a silver epoxy to ensure adequate adhesion. It would have been obvious to combine the epoxy and silane in the claimed proportions.

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6. Claims 23-27 and 57-59 are rejected under 35 U.S.C. 103(a) as obvious over Chen et al (U.S. Patent 4,975,221).

Chen et al disclose a curable epoxy adhesive for use in attaching electrical components together, such as semiconductor die or chips to a substrate, to form an electrical connection wherein the epoxy adhesive contains an electrically conductive filler and an epoxy functional silane adhesion promotor (Column 1, lines 5-11 and Column 3, line 59 to Column 4, line 5).

While Chen et al is silent towards the specifics of using the adhesive to electrically interconnect electrical components, it would have been obvious to one of ordinary skill in the art at the time the invention was made that in order to form an electrical connection between two electrical components with an adhesive, the adhesive must be interposed between the components and cured.

One skilled in the art also would have readily appreciated that it is notoriously well known and conventional when electrically connecting a semiconductor chip to a substrate that both the chip and the substrate have metal contact sites. It would have been obvious that the epoxy contacts the metal contact sites to electrically connect the chip and substrate.

Applicant teaches the contact resistance of an adhesive without an epoxy terminated silane is too high and unacceptable. Applicant also teaches that the concentration of silane in an epoxy terminated silane lowers the resistance of the adhesive and thereby lowers the contact resistance through a metal surface

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(Specification, page 6, line 15 to page 7 line 10). While Chen is silent towards the epoxy having an effective metal surface wetting concentration of silane that results in a contact resistance through the metal surface of less than or equal to about .032 ohm-cm2, Chen et al disclose the composition of the epoxy adhesive listing each component in terms of part by weight (See Column 4, lines 15-21). Applicant teaches that the effective concentration of the silane needed to obtain the desired contact resistances is less than 2% by weight or 1% by weight (Specification, page 5, lines 21-24; page 7, lines 5-10). It is clear from the composition listing in Chen et al that the adhesion promoter (epoxy functional silane) comprises less than 2% by weight or 1% by weight. One skilled in the art would have readily appreciated that the concentration of silane taught in the adhesive of Chen et al is within the effective concentration range taught by Applicant and that therefore it would be expected for the adhesive of Chen et al to have a contact resistance of the desired values (i.e. less than .3, .16, or .032 ohm-cm2).

It would have been obvious to interpose the epoxy adhesive having the disclosed composition between a semiconductor chip and a substrate, both having metal contact sites, and to then cure the adhesive into an electrically conductive bond electrically interconnecting the chip and substrate via the metal contact sites wherein the concentration of silane in the epoxy results in a contact resistance through the metal contact sites of the desired values in the method of Chen et al.

Regarding claims 57-59, it is well known and conventional for epoxy to be made conductive by adding silver to it and to add a hardener or curing agent, as shown for example in Chen et al and it is also conventional to include hardener and one skilled in

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the art would have readily appreciated it would have been within the purview of one skilled in the art to determine the necessary amount of adhesion promoter to add to a silver epoxy to ensure adequate adhesion. It would have been obvious to combine the epoxy, hardener, and silane in the claimed proportions.

7. Claims 10, 28, and 51-54 is rejected under 35 U.S.C. 103(a) as being unpatentable over Chen et al in view of Tsukagoshi et al, Kropp et al, and Inoue et al, as applied to claim 9 above and over Chen et al, as applied to claim 23 above, and further in view of Tuttle (U.S. Patent 5,558,679).

Regarding claims 10 and 28, one skilled in the art would have readily appreciated that it is well known and conventional to electrically interconnect electronic components via an epoxy adhesive wherein one of the electronic components a surface with metal containing nickel, as shown for example in Tuttle (Column 3, lines 60-61) and that Chen et al is a general teaching for interconnecting electronic parts. It would have been obvious to one of ordinary skill in the art at the time the invention was made to connect an electrical component with a nickel containing metal surface to another electrical component in the method of Chen et al, as modified above, as suggested in Tuttle.

Regarding claims 51-54, one skilled in the art would have readily appreciated that Chen et al is a general teaching for interconnecting electronic parts and that it is well known and conventional in the art to electrically interconnect two electronic components that each has a node that comprises an interface for electrically interconnecting the two components and for the adhesive to contact the interfaces, as

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shown for example in Tuttle (Column 2, line 63 to Column 3, line 29). It would have been obvious to one of ordinary skill in the art at the time the invention was made to electrically interconnect two electronic components, each having a node that comprises an interface, wherein the adhesive contacts the nodes in the method of Chen et al.

Response to Arguments

8. Applicant's arguments filed 2/10/03 have been fully considered but they are not persuasive.

Regarding claim 9, there is ample motivation to combine the references. One skilled in the art would have readily appreciated that Chen et al teach using epoxy functional silanes in general as an adhesion promoter and one skilled in the art also would have appreciated, given the general teaching of Chen, using known epoxy functional silanes as the adhesion promoter. Glycidoxy methoxy silanes, such as glycidoxypropyltrimethoxysilane, are well known and conventional epoxy functional silanes used as adhesion promoters, as evidenced by Tsukagoshi et al, Kropp et al, and Inoue et al. It would have been obvious to one of ordinary skill in the art at the time the invention was made to utilize a known epoxy functional silane adhesion promotor, such as glycidoxypropyltrimethoxysilane, in the epoxy adhesive in the method of Chen et al.

Regarding claim 23, there is no impermissible hindsight reconstruction in the rejection. Chen et al teaches having an epoxy functional silane adhesion promotor in an amount less than 2% by weight. Applicant discloses that the desired contact resistances are achieved by using a silane in an amount less than 2% by weight. Both

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Chen et al and Applicant teach having a silane concentration of less than 2% by weight.

One skilled in the art would have readily appreciated that only the expected results would be achieved in Chen et al, i.e. the desired contact resistance, from using the same concentration of silane as Applicant.

Conclusion

9. Applicant's amendment necessitated the new ground(s) of rejection presented in this Office action. Accordingly, **THIS ACTION IS MADE FINAL**. See MPEP § 706.07(a). Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the date of this final action.

10. Any inquiry concerning this communication or earlier communications from the examiner should be directed to **John T. Haran** whose telephone number is **(703) 305-0052**. The examiner can normally be reached on M-Th (8 - 5) and alternate Fridays.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Michael W. Ball can be reached on (703) 308-2058. The fax phone

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numbers for the organization where this application or proceeding is assigned are (703) 872-9310 for regular communications and (703) 872-9311 for After Final communications.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is (703) 308-

0661.

Jóhn T. Haran

March 24, 2003

Michael W. Ball pervisory Patent Examiner Technology Center 1700